

TCS3430

Color and ALS Sensor

General Description

The device features advanced digital Ambient Light Sensing (ALS) and CIE 1931 Tristimulus Color Sensing (XYZ). Each of the channels has a filter to control its optical response, which allows the device to accurately measure ambient light and sense color. These measurements are used to calculate chromaticity, illuminance and color temperature, all of which are used to support various potential applications.

Ordering Information and Content Guide appear at end of datasheet.

Key Benefits & Features

The benefits and features of the TCS3430, Color and ALS Sensor are listed below:

Figure 1: Added Value of Using TCS3430

Benefits	Features
Improves ALS responsiveness of the system	Capable of ±10% illuminance and correlated color temperature accuracy
Reduces board space requirements and enables low-profile system design	Small footprint and low profile package: 2.41mm x 1.75mm x 1.00mm
Improves ALS response for more accurate measurement of lighting environment	Advanced interference filter technology
Enables accurate color and ALS sensing under varying lighting conditions and behind dark glass	Wide dynamic range and high sensitivity
Enables accurate color temperature calculations and ambient light sensing	XYZ tristimulus filters Programmable gain and integration time
Low power consumption	1.8V supply voltage and I ² C bus

Applications

The TCS3430 applications include:

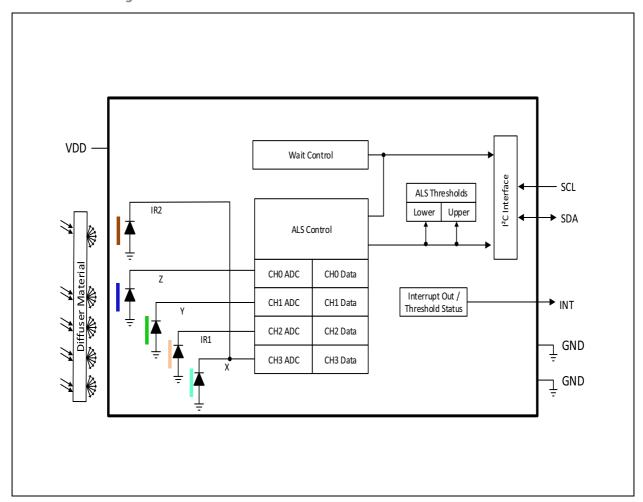
- Display management
- Camera image correction and enhancement
- Color sensing
- Ambient light sensing
- · Optical identification
- Color matching



Block Diagram

The functional blocks of this device are shown below:

Figure 2: TCS3430 Block Diagram



Page 2ams DatasheetDocument Feedback[v1-11] 2019-Aug-05



Pin Assignment

Figure 3: TCS3430 Pinout (Top View)

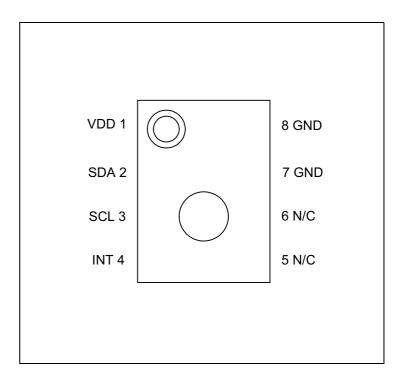


Figure 4: Pin Description

Pin Number	Pin Name	Description			
1	VDD	Supply voltage			
2	SDA	I ² C serial data I/O terminal			
3	SCL	I ² C serial clock input terminal			
4	INT	Interrupt. Open drain output (active low)			
5	N/C	No connection. May be connected to Ground or not connected.			
6	N/C	No connection. May be connected to Ground or not connected.			
7	GND	Ground. All voltages are referenced to GND			
8	GND	Ground. All voltages are referenced to GND			

ams DatasheetPage 3[v1-11] 2019-Aug-05Document Feedback



Absolute Maximum Ratings

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only. Functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Figure 5:
Absolute Maximum Ratings

Symbol	Parameter	Min	Max	Units
V _{DD}	Supply voltage	-0.3	2.2	V
V _{IO}	Digital I/O terminal voltage	-0.3	3.6	V
I _{IO}	Output terminal current	-1	20	mA
T _{STRG}	Storage temperature range	-40	85	°C
Тл	Junction temperature range	-40	90	°C
ESD _{HBM}	Electrostatic discharge HBM (JS-001-2014)	±2	2000	V
ESD _{CDM}	Electrostatic discharge CDM JEDEC JESD22-C101F Oct 2013	±	V	
I _{SCR}	Input current (latch up immunity) JEDEC JESD78D Nov 2011	CLASS 2		

Page 4ams DatasheetDocument Feedback[v1-11] 2019-Aug-05



Electrical Characteristics

Figure 6:

Recommended Operating Conditions

Symbol	Parameter	Min	Тур	Max	Units
V _{DD}	Supply voltage	1.7	1.8	2.0	V
T _A	Operating free-air temperature (1)	-30		85	°C

Note(s):

1. While the device is operational across the temperature range, performance will vary with temperature. Operational characteristics are at 25°C, unless otherwise noted.

Figure 7: Operating Characteristics, $V_{DD} = 1.8 \text{ V}$, $T_A = 25 ^{\circ}\text{C}$ (unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
f _{OSC}	Oscillator frequency			8.1		MHz
		Active ALS state (PON=AEN=1) (2)		100	150	μΑ
I _{DD}	Supply current (1)	Idle state (PON=1, AEN=0) (3)		30	60	μΛ
		Sleep State ⁽⁴⁾		0.7	5.0	μΑ
V _{OL}	INT, SDA output low voltage	6 mA sink current			0.6	V
I _{LEAK}	Leakage current, SDA, SCL, INT, pins		-5		5	μΑ
V _{IH}	SCL, SDA input high voltage		1.26			V
V _{IL}	SCL, SDA input low voltage				0.54	V

Note(s):

- 1. Values are shown at the VDD pin.
- 2. This parameter indicates the supply current during periods of ALS integration. If Wait is enabled (WEN=1), the supply current is lower during the Wait period.
- 3. Idle state occurs when PON=1 and all functions are not enabled.
- 4. Sleep state occurs when PON = 0 and l^2C bus is idle. If Sleep state has been entered as the result of operational flow, SAI = 1, PON will remain high.

ams Datasheet Page 5
[v1-11] 2019-Aug-05 Document Feedback



Figure 8: Optical Characteristics

Parameter	Channel	Light Source	Min	Тур	Max	Units
	Х		58	74	90	
	Y	Warm White LED (2700K, 25 μW/cm ²)	56	62	70	
Irradiance Responsivity 16x gain, 400ms ⁽¹⁾	Z	•	6.5	10.3	14	counts/
	IR1	Far Red LED $(\lambda = 730 \text{nm}, 11.6 \ \mu\text{W/cm}^2)$	90 135 180 (μW		(μW/cm ²)	
	IR2	IR LED $(\lambda = 950 \text{nm}, 41.8 \mu\text{W/cm}^2)$	90	160	230	

Note(s):

1. Tested using collimated light sources.

Figure 9:

Filter Characteristics

Symbol	Parameter	Min	Тур	Max	Units
λ_Χ1	Peak 1 wavelength of channel X	427	437	447	nm
λ_X2	Peak 2 wavelength of channel X	564	574	584	nm
λ_Υ	Peak wavelength of channel Y	527	537	547	nm
λ_Z	Peak wavelength of channel Z	424	434	444	nm
FWHM_X1	Full width at half maximum of channel X peak 1	45	55	65	nm
FWHM_X2	Full width at half maximum of channel X peak 2	83	93	103	nm
FWHM_Y	Full width at half maximum of channel Y	92	102	112	nm
FWHM_Z	Full width at half maximum of channel Z	53	63	73	nm
T50L_IR1	Lower edge of IR1 at 50% of transition	672	687	702	nm
T50H_IR1	Higher edge of IR1 at 50% of transition	815	830	845	nm
T50_IR2	At 50% of transition of IR2	812	827	842	nm

Note(s):

1. Filter parameters are measured on a production ongoing sample basis using diffused light.

Page 6ams DatasheetDocument Feedback[v1-11] 2019-Aug-05



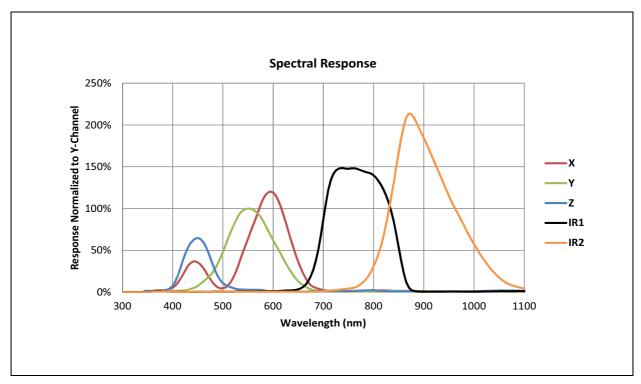
Figure 10: ALS Operating Characteristics, VDD = 1.8 V, T_A = 25°C, AGAIN = 16x, ATIME = 0x09 (27ms) (unless otherwise noted)

Parameter	Conditions	Min	Тур	Max	Units
Integration time step size		2.64	2.78	2.92	ms
Dark ADC count value	Ee = 0 μW/cm ² AGAIN: 64x ATIME: 100ms (0x23)	0	1	3	counts
	AGAIN: 4x		4		
Gain scaling, relative to 1x	AGAIN: 16x		16		
gain setting	AGAIN: 64x		66		
	AGAIN: 128x		137		
ADC noise	AGAIN: 16x		0.005		% full scale

ams Datasheet Page 7
[v1-11] 2019-Aug-05 Document Feedback



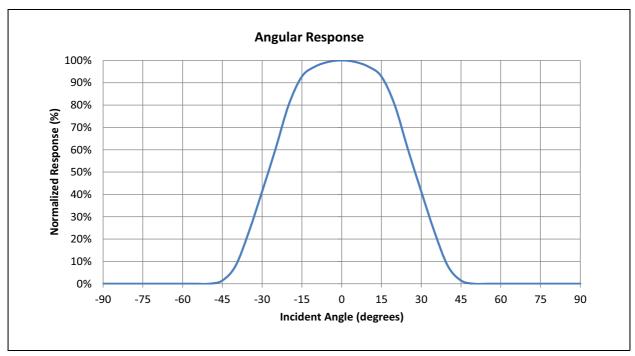
Figure 11: Spectral Response



Note(s):

1. Response is measured with a diffuser on the surface of TCS3430 that matches the minimum recommended scattering characteristic shown in Figure 40.

Figure 12: ALS Average Angular Response



Note(s):

1. Response is measured without a diffuser on the surface of TCS3430 that matches the minimum recommended scattering characteristic shown in Figure 40.

Page 8
Document Feedback
[v1-11] 2019-Aug-05



I²C Protocol

The device uses I²C serial communication protocol for communication. The device supports 7-bit chip addressing and both standard and full-speed clock frequency modes. Read and Write transactions comply with the standard set by Philips (now NXP).

Note(s): The I²C device address can be found in Ordering Information.

Internal to the device, an 8-bit buffer stores the register address location of the desired byte to read or write. This buffer auto-increments upon each byte transfer and is retained between transaction events (I.e. valid even after the master issues a STOP command and the I²C bus is released). During consecutive Read transactions, the future/repeated I²C Read transaction may omit the memory address byte normally following the chip address byte; the buffer retains the last register address +1.

All 16-bit fields have a latching scheme for reading and writing. In general it is recommended to use I²C bursts whenever possible, especially in this case when accessing two bytes of one logical entity. When reading these fields, the low byte must be read first, and it triggers a 16-bit latch that stores the 16-bit field. The high byte must be read immediately afterwards. When writing to these fields, the low byte must be written first, immediately followed by the high byte. Reading or writing to these registers without following these requirements will cause errors.

I²C Write Transaction

A Write transaction consists of a START, CHIP-ADDRESSWRITE, REGISTER-ADDRESS WRITE, DATA BYTE(S), and STOP. Following each byte (9TH clock pulse) the slave places an ACKNOWLEDGE/NOT- ACKNOWLEDGE (ACK/NACK) on the bus. If NACK is transmitted by the slave, the master may issue a STOP.

I²C Read Transaction

A Read transaction consists of a START, CHIP-ADDRESSWRITE, REGISTER-ADDRESS, RESTART, CHIP-ADDRESSREAD, DATA BYTE(S), and STOP. Following all but the final byte the master places an ACK on the bus (9TH clock pulse). Termination of the Read transaction is indicated by a NACK being placed on the bus by the master, followed by STOP.

The I²C bus protocol was developed by Philips (now NXP). For a complete description of the I²C protocol, please review the NXP I²C design specification.

ams Datasheet Page 9 Document Feedback



Register Description

Figure 13: Register Overview

Address	Register Name	R/W	Register Function	Reset Value
0x80	ENABLE	R/W	Enables states and interrupts	0x00
0x81	ATIME	R/W	ADC integration time	0x00
0x83	WTIME	R/W	ALS wait time	0x00
0x84	AILTL	R/W	ALS interrupt low threshold low byte	0x00
0x85	AILTH	R/W	ALS interrupt low threshold high byte	0x00
0x86	AIHTL	R/W	ALS interrupt high threshold low byte	0x00
0x87	AIHTH	R/W	ALS interrupt high threshold high byte	0x00
0x8C	PERS	R/W	ALS interrupt persistence filters	0x00
0x8D	CFG0	R/W	Configuration register zero	0x80
0x90	CFG1	R/W	Configuration register one	0x00
0x91	REVID	R	Revision ID	0x41
0x92	ID	R	Device ID	0xDC
0x93	STATUS	R	Device status register one	0x00
0x94	CH0DATAL	R	Z CH0 ADC Low Byte Register	0x00
0x95	CH0DATAH	R	Z CH0 ADC High Byte Register	0x00
0x96	CH1DATAL	R	Y Ch1 ADC Low Byte Register	0x00
0x97	CH1DATAH	R	Y CH1 ADC High Byte Register	0x00
0x98	CH2DATAL	R	IR1 - CH2 ADC Low Byte Register	0x00
0x99	CH2DATAH	R	IR1 - Ch2 ADC High Byte Register	0x00
0x9A	CH3DATAL	R	X or IR2 - CH3 ADC Low Byte Register	0x00
0x9B	CH3DATAH	R	X or IR2 - CH3 ADC High Byte Register	0x00
0x9F	CFG2	R/W	Configuration register two	0x04
0xAB	CFG3	R/W	Configuration register three	0x00
0xD6	AZ_CONFIG	R/W	Auto zero configuration	0x7F
0xDD	INTENAB	R/W	Interrupt enables	0x00

Note(s):

1. Register Access:

R = Read Only

W = Write Only

R/W = Read or Write

SC = Self Clearing after access

Page 10ams DatasheetDocument Feedback[v1-11] 2019-Aug-05



ENABLE Register (0x80)

Figure 14: **ENABLE Register**

	0x80: ENABLE							
Field	Name	Reset	Type	Description				
7:4	RESERVED	0	RW	Reserved				
3	WEN	0	RW	Wait Enable. This bit activates the wait feature. Writing a one actives the wait timer. Writing a zero disables the wait timer.				
2	RESERVED	0	RW	Reserved				
1	AEN	0	RW	ALS Enable. This bit actives the ALS function. Set aen=1 and pon=1 in the same command to ensure autozero function is run prior to the first measurement.				
0	PON	0	RW	Power ON. This field activates the internal oscillator to permit the timers and ADC channels to operate. Writing a one activates the oscillator. Writing a zero disables the oscillator.				

The mode/parameter fields should be written before AEN is asserted. The function AEN requires PON to be asserted to operate correctly.

ams Datasheet Page 11 Document Feedback



ATIME Register (0x81)

Figure 15: ATIME Register

0x81: ATIME								
Field	Name	Reset	Type		Des	cription		
			0x00 RW	in 2.78ms into The maximur every 2.78ms	ervals. 0x00 indica m ALS value deper ,, the maximum va e to reach ALS full	tes 2.78ms, 0x01 inds on the integra lue increases by 1	ition time. For	
				Value	Integration Cycles	Integration Time	Maximum ALS Value	
7:0	ATIME	0x00		0x00	1	2.78ms	1023	
				0x01	2	5.56ms	2047	
				0x11	18	50ms	18431	
				0x40	65	181ms	65535	
				•••		•••		
				0xff	256	711ms	65535	

The ATIME register controls the integration time of the ALS ADCs.

The timer is implemented with a down counter with 0x00 as the terminal count. The timer is clocked at a 2.78ms nominal rate. Loading 0x00 will generate a 2.78ms integration time, loading 0x01 will generate a 5.56ms integration time, and so forth.

Page 12ams DatasheetDocument Feedback[v1-11] 2019-Aug-05



WTIME Register (0x83)

Figure 16: WTIME Register

	0x83: WTIME								
Field	Name	Reset	Туре		Description				
ALS Wait Time. Eight bit value that specifies the time in 2.78ms between ALS cycles.									
				Value	Wait Cycles	Wait Time			
			0x00 RW	0x00	1	2.78ms/ 33.4ms			
7:0	WTIME	0x00		0x01	2	5.56ms/ 66.7ms			
				0x23	36	100ms/ 1.20s			
				0xff	256	711ms/ 8.53s			

The wait timer is implemented with an down counter with 0x00 as the terminal count. Loading 0x00 will generate a 2.78ms wait time, loading 0x01 will generate a 5.56ms wait time, and so forth; By asserting wlong, in register 0x8D the wait time is given in multiples of 33.4ms (12x).

AILTL Register (0x84)

Figure 17: AILTL Register

	0x84: AILTL						
Field	Name	Reset	Type	Description			
7:0	AILTL	0x00	RW	Low Byte of the Low Threshold			

This register provides the low byte of the low interrupt ALS (Channel 0) threshold.

ams Datasheet Page 13
[v1-11] 2019-Aug-05 Document Feedback



AILTH Register (0x85)

Figure 18: AILTH Register

	0x85: AILTH						
Field	Name	Reset	Type	Description			
7:0	AILTH	0x00	RW	High Byte of the Low Threshold			

This register provides the high byte of the low interrupt ALS (Channel 0) threshold.

The contents of the AILTH and AILTL registers are combined and treated as a sixteen bit threshold. If the value generated by Channel 0 is below the low threshold specified and the APERS value is reached, the aint bit is asserted which will assert the INT pin if aien is set.

There is an 8-bit data latch implemented that stores the written low byte until the high byte is written. Both bytes will be applied then at the same time to avoid an invalid threshold (e.g. when going from 0x00ff to 0x0100, the invalid intermediate value 0x0000 is suppressed. This implies that 1) the LSB cannot be changed without writing to the MSB and 2) that writing to the LSB of one 16-bit value and afterwards to the MSB of another 16-bit register will write all 16 bits to the MSB related register.

Page 14ams DatasheetDocument Feedback[v1-11] 2019-Aug-05



AIHTL Register (0x86)

Figure 19: **AIHTL Register**

0x86: AIHTL						
Field	Name	Reset	Type	Description		
7:0	AIHTL	0	RW	Low Byte of the High Threshold		

This register provides the low byte of the high interrupt threshold.

AIHTH Register (0x87)

Figure 20: **AIHTH Register**

	0x87: AIHTH						
Field	Name	Reset	Type	Description			
7:0	AIHTH	0	RW	High Byte of the High Threshold			

This register provides the low byte of the high interrupt threshold.

The contents of the AIHTH and AIHTL registers are combined and treated as a sixteen bit threshold. If the value generated by Channel 0 is above the high threshold specified and the APERS value is reached, the aint bit is asserted which will assert the INT pin if aien is set.

ams Datasheet Page 15 **Document Feedback**



PERS Register (0x8C)

Figure 21: PERS Register

				0x8C: PEF	RS	
Field	Name	Reset	Туре		Description	
7:4	RESERVED	0	RW	Reserved		
				Value	Interrupt Generated When	
				0	Every ALS cycle	
			1	Any ALS value outside of threshold range		
				2	2 consecutive ALS values out of range	
				3	3 consecutive ALS values out of range	
			RW	0 RW	4	5
3:0	APERS	0			5	10
				6	15	
				7	20	
				12	45	
			13	50		
				14	55	
				15	60 consecutive ALS values out of range	

This register controls the interrupt filtering capabilities of the device. Configurable filtering is provided to allow interrupts to be generated after either an ALS integration cycle or if the integration cycle has produced a result that is outside of the values specified by threshold register for some specified number of times.

ALS interrupts are generated by looking only at the ADC integration results of Channel 0 photodiode.

Page 16ams DatasheetDocument Feedback[v1-11] 2019-Aug-05



CFG0 Register (0x8D)

Figure 22: CFG0 Register

	0x8D: CFG0							
Field	Name	Reset	Type	Description				
7:3	RESERVED	10000	RW	Reserved. Must be set to 10000.				
2	WLONG	0	RW	Wait Long. When asserted, the wait cycle is increased by a factor 12x from that programmed in the WTIME register.				
1:0	RESERVED	0 0	RW	Reserved. Must be set to 00.				

CFG1 Register (0x90)

Figure 23: CFG1 Register

	0x90: CFG1							
Field	Name	Reset	Туре	Descr	iption			
7:4	RESERVED	0	RW	Reserved				
3	AMUX	0	RW	ALS Multiplexer. Sets the Channel). Set to 1 to read	CH3 input. Default = 0 (X IR2.			
2	RESERVED	0	RW	Reserved				
			RW	ALS Gain Control. Sets the	e gain of the ALS DAC.			
		0		Field Value	Gain			
1:0	AGAIN			00	1x			
1.0	AGAIN		1117	01	4x			
				10	16x			
				11	64x			

 $\textbf{CFG1 Register:} \ \text{Register CFG1 sets the gain level for ALS measurements.} \ \text{The valid range of values is } 0 \times 00 - 0 \times 03.$

ams Datasheet Page 17
[v1-11] 2019-Aug-05 Document Feedback



REVID Register (0x91)

Figure 24: **REVID Register**

0x91: REVID						
Field	Name	Reset	Type	Description		
7:3	RESERVED	01000	RO	Reserved		
2:0	REV_ID	001	RO	Revision Number Identification		

ID Register (0x92)

Figure 25: **ID Register**

	0x92: ID							
Field	Name	Reset	Type	Descr	iption			
				Part Number Identification				
7:2	ID	110111	RO	Value	Meaning			
				110111	TCS3430			
1:0	RESERVED	00	RO	Reserved				

Page 18 $ams\, Datasheet$ **Document Feedback** [v1-11] 2019-Aug-05



STATUS Register (0x93)

Figure 26: **STATUS Register**

	0x93: STATUS						
Field	Name	Reset	Type	Description			
7	ASAT	0	R, SC	ALS Saturation. This flag is set for analog saturation writing a 1 will clear this status flag.			
6:5	RESERVED	0	R, SC	Reserved			
4	AINT	0	R, SC	ALS Interrupt. Indicates that the device is asserting an ALS interrupt. writing a 1 will clear this status flag.			
3:0	RESERVED	0	R, SC	Reserved			

CHODATAL Register (0x94)

Figure 27: **CHODATAL** Register

0x94: CH0DATAL						
Field	Name	Reset	Type	Description		
7:0	CH0DATAL	0	RO	Low Byte of CH0 ADC data. Contains Z data.		

CHODATAH Register (0x95)

Figure 28: **CHODATAH Register**

	0x95: CH0DATAH						
Field	Name	ame Reset Type		Description			
7:0	CH0DATAH	0	RO	High Byte of CH0 ADC data. Contains Z data.			

ams Datasheet Page 19 Document Feedback



CH1DATAL Register (0x96)

Figure 29: **CH1DATAL** Register

0x96: CH1DATAL						
Field Name Reset Type Description				Description		
7:0 CH1DATAL 0 RO Low Byte of CH1 ADC data. Contains Y data.						

CH1DATAH Register (0x97)

Figure 30: **CH1DATAH Register**

0x97: CH1DATAH						
Field Name Reset Type Description						
7:0 CH1DATAH 0 RO High Byte of CH1 ADC data. Contains Y data.						

CH2DATAL Register (0x98)

Figure 31: **CH2DATAL** Register

0x98: CH2DATAL						
Field	Field Name Reset Type Description					
7:0	CH2DATAL	0	RO	Low Byte of CH2 ADC data. Contains IR1 data.		

CH2DATAH Register (0x99)

Figure 32: **CH2DATAH Register**

0x99: CH2DATAH						
Field	Field Name Reset Type Description					
7:0	CH2DATAH	0	RO	High Byte of CH2 ADC data. Contains IR1 data.		

Page 20 ams Datasheet **Document Feedback** [v1-11] 2019-Aug-05



CH3DATAL Register (0x9A)

Figure 33: **CH3DATAL** Register

	0x9A: CH3DATAL						
Field Name Reset Type Description							
7:0	CH3DATAL	0	RO	Low Byte of CH3 ADC data. If AMUX = 0 contains X data. If AMUX = 1 contains IR2 data. Default = X data.			

CH3DATAH Register (0x9B)

Figure 34: **CH3DATAH Register**

	0x9B: CH3DATAH							
Field Name Reset Type Description								
7:0	CH3DATAH	0	RO	High Byte of CH3 ADC data. If AMUX = 0 contains X data. If AMUX = 1 contains IR2 data. Default = X data.				

CFG2 Register (0x9F)

Figure 35: **CFG2** Register

	0x9F: CFG2							
Field Name Reset Type Description								
7:5	Reserved	000	RW	Reserved. Set to 000.				
4	HGAIN	0	RW	High 128x gain. If this bit is set and AGAIN in the CFG1 register is set to 11, then the 128x gain mode will be enabled.				
3:0	Reserved	0100	RW	Reserved. Set to 0100.				

ams Datasheet Page 21 Document Feedback



CFG3 Register (0xAB)

Figure 36: CFG3 Register

0xAB: CFG3								
Field	Name	Reset	Type		Description			
7	INT_READ_CLEAR	0	RW		If this bit is set, all flag bits in the STATUS register will be reset whenever the STATUS register is read over I ² C.			
6:5	RESERVED	0	RW	Reserve	d. Set to 0.			
				Sleep After Interrupt. Power down the device at the end of the ALS cycle if an interrupt has been generated. (1)				
				PON	SAI	INT (low active)	Oscillator	
		_		0	х	х	OFF	
4	SAI	0	RW	1	0	х	ON	
				1	1	1	ON	
				1	1	0	OFF (SAI induced sleep)	
						up" the device upt register 0x	from SAI-sleep is by 93.	
3:0	RESERVED	0	RW	Reserve	d. Set to 0.			

Note(s):

1. SAI does not modify any register bits directly, it rather uses the interrupt signal to turn OFF the oscillator.

Page 22ams DatasheetDocument Feedback[v1-11] 2019-Aug-05



AZ_CONFIG Register (0xD6)

Figure 37: **AZ_CONFIG Register**

0xD6: AZ_CONFIG							
Field Name Reset Type Description							
7	AZ_MODE	0	RW	0: Always start at zero when searching the best offset value 1: Always start at the previous (offset_c) with the auto-zero mechanism (1)			
6:0	AZ_NTH_ ITERATION	0x7F	RW	Run autozero automatically every nth ALS iteration (0=never, 7Fh=only at first ALS cycle, n=every nth time)			

Note(s):

1. On average mode 1 is faster, but in the worst case, mode 0 is faster.

INTENAB Register (0xDD)

Figure 38: **INTENAB** Register

	0xDD: INTENAB							
Field	Name	Name Reset Type Description						
7	ASIEN	0	RW	Writing '1' to this bit enables ASAT interrupt.				
6:5	RESERVED	0	RW	Reserved				
4	AIEN	0	RW	Writing '1' to this bit enables ALS interrupt.				
3:0	RESERVED	0	RW	Reserved				

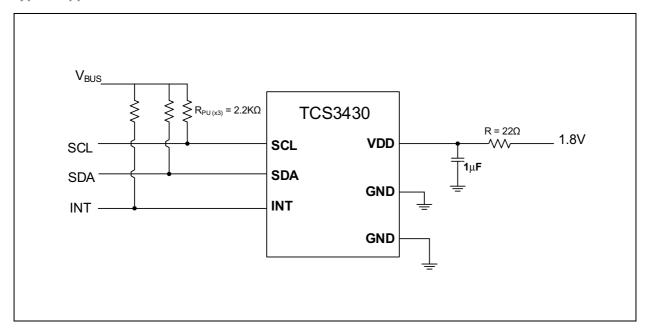
ams Datasheet Page 23 Document Feedback



Application Information

Figure 39:

Typical Application Hardware Circuit



Note(s):

- 1. Place the $1\mu\text{F}$ capacitors as close as possible to the module.
- $2. V_{DD} = 1.8 V, V_{BUS} = 1.8 V.$
- 3. The N/C pins (5 and 6) that are not indicated in the circuit diagram may be connected to GND or not connected (remain open).

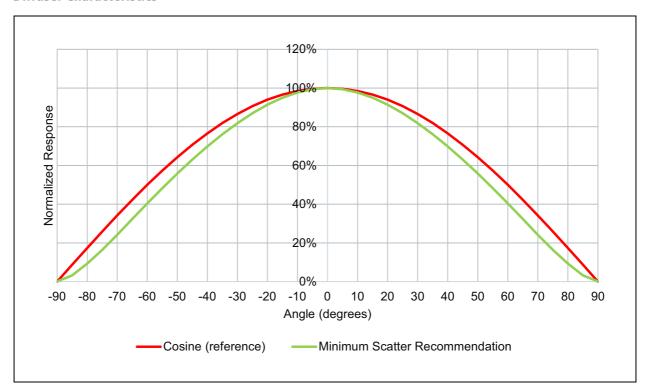
Page 24ams DatasheetDocument Feedback[v1-11] 2019-Aug-05



Application Optical Requirements

For optimal performance an achromatic diffuser shall be placed above the device aperture. The recommended solution is a bulk diffuser that meets the minimum recommended scattering characteristic shown below. For more details refer to the Optical Design Guide or contact **ams**.

Figure 40:
Diffuser Characteristics

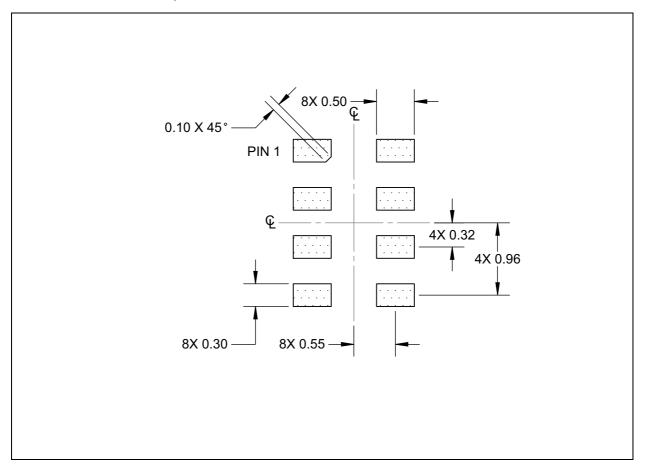


ams Datasheet Page 25
[v1-11] 2019-Aug-05 Document Feedback



PCB Pad Layout

Figure 41: Recommended PCB Pad Layout



Note(s):

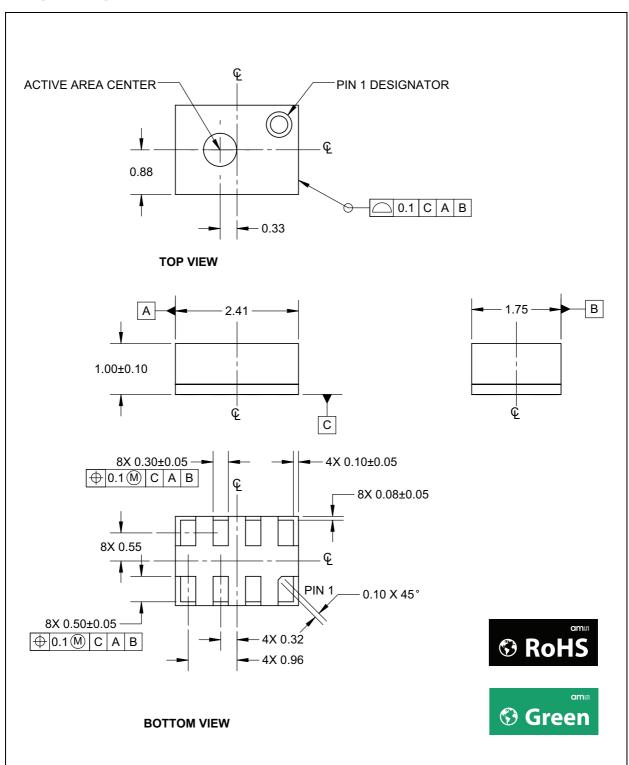
- 1. All linear dimensions are in millimeters.
- 2. Dimension tolerances are 0.05mm unless otherwise noted.
- 3. This drawing is subject to change without notice.
- 4. Layout as shown when viewed from above.

Page 26ams DatasheetDocument Feedback[v1-11] 2019-Aug-05



Packaging Mechanical Data

Figure 42: **Package Drawing**



Note(s):

- 1. All linear dimensions are in millimeters.
- 2. Contact finish is Au.
- 3. This package contains no lead (Pb).
- 4. This drawing is subject to change without notice.

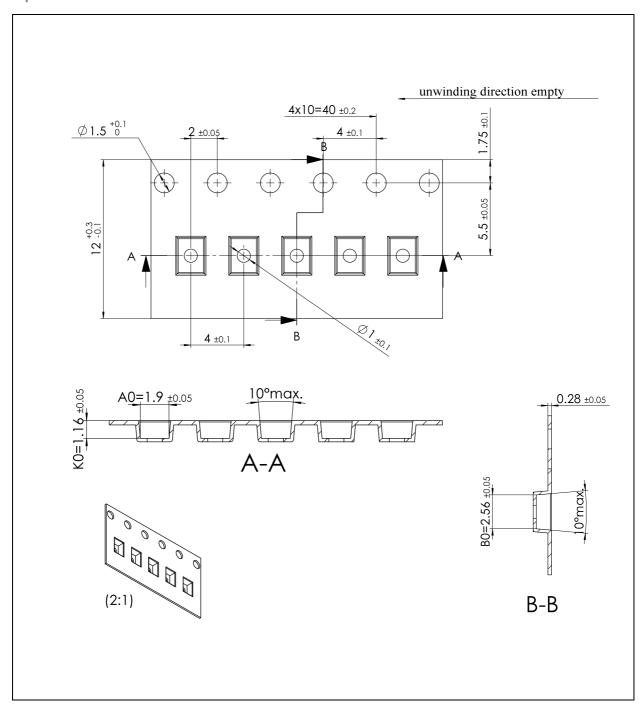
ams Datasheet Page 27 **Document Feedback**



Tape & Reel Information

Figure 43:

Tape & Reel Information



Note(s):

- 1. All linear dimensions are in millimeters.
- 2. For missing tolerances and dimensions, refer to EIA-481.

Page 28ams DatasheetDocument Feedback[v1-11] 2019-Aug-05



Soldering & Storage Information

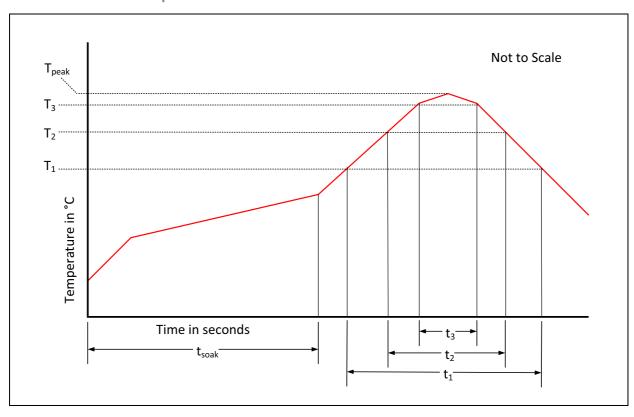
The module has been tested and has demonstrated an ability to be reflow soldered to a PCB substrate.

The solder reflow profile describes the expected maximum heat exposure of components during the solder reflow process of product on a PCB. Temperature is measured on top of component. The components should be limited to a maximum of three passes through this solder reflow profile.

Figure 44: Solder Reflow Profile

Parameter	Reference	Device
Average temperature gradient in preheating		2.5°C/s
Soak time	t _{soak}	2 to 3 minutes
Time above 217°C (T ₁)	t ₁	Max 60s
Time above 230°C (T ₂)	t ₂	Max 50s
Time above T _{peak} – 10 °C (T ₃)	t ₃	Max 10s
Peak temperature in reflow	T_{peak}	260°C
Temperature gradient in cooling		Max -5°C/s

Figure 45: Solder Reflow Profile Graph



ams Datasheet Page 29
[v1-11] 2019-Aug-05 Document Feedback



Storage Information

Moisture Sensitivity

Optical characteristics of the device can be adversely affected during the soldering process by the release and vaporization of moisture that has been previously absorbed into the package. To ensure the package contains the smallest amount of absorbed moisture possible, each device is baked prior to being dry packed for shipping.

Devices are dry packed in a sealed aluminized envelope called a moisture-barrier bag with silica gel to protect them from ambient moisture during shipping, handling, and storage before use.

Shelf Life

The calculated shelf life of the device in an unopened moisture barrier bag is 12 months from the date code on the bag when stored under the following conditions:

· Shelf Life: 12 months

• Ambient Temperature: <40°C

• Relative Humidity: <90%

Rebaking of the devices will be required if the devices exceed the 12 month shelf life or the Humidity Indicator Card shows that the devices were exposed to conditions beyond the allowable moisture region.

Floor Life

The module has been assigned a moisture sensitivity level of MSL 3. As a result, the floor life of devices removed from the moisture barrier bag is 168 hours from the time the bag was opened, provided that the devices are stored under the following conditions:

• Floor Life: 168 hours

• Ambient Temperature: <30°C

• Relative Humidity: <60%

If the floor life or the temperature/humidity conditions have been exceeded, the devices must be rebaked prior to solder reflow or dry packing.

Rebaking Instructions

When the shelf life or floor life limits have been exceeded, rebake at 50°C for 12 hours.

Page 30

Document Feedback

[v1-11] 2019-Aug-05



Ordering & Contact Information

Figure 46: **Ordering Information**

Ordering Code	I ² C Bus	I ² C Addr	Delivery Form	Delivery Quantity
TCS34303	1.8V	0x39	Tape & Reel (13")	10000 pcs/reel

Buy our products or get free samples online at:

www.ams.com/Products

Technical Support is available at: www.ams.com/Technical-Support

Provide feedback about this document at:

www.ams.com/Document-Feedback

For further information and requests, e-mail us at: ams_sales@ams.com

For sales offices, distributors and representatives, please visit: www.ams.com/Contact

Headquarters

ams AG **Tobelbader Strasse 30** 8141 Premstaetten Austria, Europe

Tel: +43 (0) 3136 500 0 Website: www.ams.com

ams Datasheet Page 31 **Document Feedback**



RoHS Compliant & ams Green Statement

RoHS: The term RoHS compliant means that ams AG products fully comply with current RoHS directives. Our semiconductor products do not contain any chemicals for all 6 substance categories, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, RoHS compliant products are suitable for use in specified lead-free processes.

ams Green (RoHS compliant and no Sb/Br): ams Green defines that in addition to RoHS compliance, our products are free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material).

Important Information: The information provided in this statement represents ams AG knowledge and belief as of the date that it is provided. ams AG bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. ams AG has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. ams AG and ams AG suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

Page 32

Document Feedback

[v1-11] 2019-Aug-05



Copyrights & Disclaimer

Copyright ams AG, Tobelbader Strasse 30, 8141 Premstaetten, Austria-Europe. Trademarks Registered. All rights reserved. The material herein may not be reproduced, adapted, merged, translated, stored, or used without the prior written consent of the copyright owner.

Devices sold by ams AG are covered by the warranty and patent indemnification provisions appearing in its General Terms of Trade. ams AG makes no warranty, express, statutory, implied, or by description regarding the information set forth herein. ams AG reserves the right to change specifications and prices at any time and without notice. Therefore, prior to designing this product into a system, it is necessary to check with ams AG for current information. This product is intended for use in commercial applications. Applications requiring extended temperature range, unusual environmental requirements, or high reliability applications, such as military, medical life-support or life-sustaining equipment are specifically not recommended without additional processing by ams AG for each application. This product is provided by ams AG "AS IS" and any express or implied warranties, including, but not limited to the implied warranties of merchantability and fitness for a particular purpose are disclaimed.

ams AG shall not be liable to recipient or any third party for any damages, including but not limited to personal injury, property damage, loss of profits, loss of use, interruption of business or indirect, special, incidental or consequential damages, of any kind, in connection with or arising out of the furnishing, performance or use of the technical data herein. No obligation or liability to recipient or any third party shall arise or flow out of ams AG rendering of technical or other services.

ams Datasheet Page 33 **Document Feedback**



Document Status

Document Status	Product Status	Definition
Product Preview	Pre-Development	Information in this datasheet is based on product ideas in the planning phase of development. All specifications are design goals without any warranty and are subject to change without notice
Preliminary Datasheet	Pre-Production	Information in this datasheet is based on products in the design, validation or qualification phase of development. The performance and parameters shown in this document are preliminary without any warranty and are subject to change without notice
Datasheet	Production	Information in this datasheet is based on products in ramp-up to full production or full production which conform to specifications in accordance with the terms of ams AG standard warranty as given in the General Terms of Trade
Datasheet (discontinued)	Discontinued	Information in this datasheet is based on products which conform to specifications in accordance with the terms of ams AG standard warranty as given in the General Terms of Trade, but these products have been superseded and should not be used for new designs

Page 34ams DatasheetDocument Feedback[v1-11] 2019-Aug-05



Revision Information

Changes from 1-10 (2018-Mar-08) to current revision 1-11 (2019-Aug-05)	Page
Updated Figure 40	25

Note(s):

- 1. Page and figure numbers for the previous version may differ from page and figure numbers in the current revision.
- $2. \, Correction \, of \, typographical \, errors \, is \, not \, explicitly \, mentioned.$

ams Datasheet Page 35 Document Feedback



Content Guide

1 General Description

- 1 Key Benefits & Features
- 1 Applications
- 2 Block Diagram
- 3 Pin Assignment
- 4 Absolute Maximum Ratings
- 5 Electrical Characteristics

10 I²C Protocol

- 10 I²C Write Transaction
- 10 I²C Read Transaction

11 Register Description

- 12 ENABLE Register (0x80)
- 13 ATIME Register (0x81)
- 14 WTIME Register (0x83)
- 14 AILTL Register (0x84)
- 15 AILTH Register (0x85)
- 16 AIHTL Register (0x86)
- 16 AIHTH Register (0x87)
- 17 PERS Register (0x8C)
- 18 CFG0 Register (0x8D)
- 18 CFG1 Register (0x90)
- 19 REVID Register (0x91)
- 19 ID Register (0x92)
- 20 STATUS Register (0x93)
- 20 CH0DATAL Register (0x94)
- 20 CH0DATAH Register (0x95)
- 21 CH1DATAL Register (0x96)
- 21 CH1DATAH Register (0x97)21 CH2DATAL Register (0x98)
- 21 CH2DATAH Register (0x99)
- 22 CH3DATAL Register (0x9A)
- 22 CH3DATAH Register (0x9B)
- 22 CFG2 Register (0x9F)
- 23 CFG3 Register (0xAB)
- 24 AZ_CONFIG Register (0xD6)
- 24 INTENAB Register (0xDD)

25 Application Information

- 26 Application Optical Requirements
- 27 PCB Pad Layout
- 28 Packaging Mechanical Data
- 29 Tape & Reel Information

30 Soldering & Storage Information

- 31 Storage Information
- 31 Moisture Sensitivity
- 31 Shelf Life
- 31 Floor Life
- 31 Rebaking Instructions

Page 36
Document Feedback
[v1-11] 2019-Aug-05



- 32 Ordering & Contact Information
- 33 RoHS Compliant & ams Green Statement34 Copyrights & Disclaimer
- 35 Document Status
- **36 Revision Information**

ams Datasheet Page 37 [v1-11] 2019-Aug-05 Document Feedback